

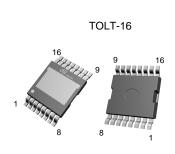
N-Channel 150 V (D-S) MOSFET

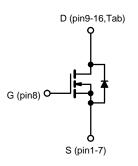
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)			
150	0.0062 at V _{GS} = 10 V	150	100 nC			

FEATURES

- SGT technology Power MOSFET
- Maximum 175°C junction temperature
- 100 % R_g and UIS tested







N-Channel MOSFET

APPLICATIONS

- Power supplies:
 - Uninterruptible power supplies
 - AC/DC switch-mode power supplies
 - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- · Solar micro inverter
- Class D audio amplifier

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	LIMIT	UNIT				
Drain-Source Voltage	V _{DS}	150	V				
Gate-Source Voltage	V _{GS}	± 20	V				
Continuous Drain Current /T 150 °C\	T _C = 25 °C		150	A			
Continuous Drain Current (T _J = 150 °C)	T _C = 100 °C		120				
Pulsed Drain Current (t = 100 μs)	I _{DM}	ом 600					
Avalanche Current L = 0.5 mH		I _{AS}	75				
Single Avalanche Energy ^a	L = 0.5 IIIH	E _{AS}	1370	mJ			
Maximum Dawar Dissination 8	T _C = 25 °C	В	375 ^b	W			
Maximum Power Dissipation ^a	T _C = 100 °C	$ P_D$	187.5 ^b	\ \v\			
Operating Junction and Storage Temperature I	T _J , T _{stg}	-55 to +175	°C				

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	LIMIT	UNIT			
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	62	°C/W			
Junction-to-Case (Drain)	R _{thJC}	0.4				

Notes

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).

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PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT		
Static	1						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	150	-	-	٧	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4		
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA	
		V _{DS} = 120 V, V _{GS} = 0 V	-	-	1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 120 V, V _{GS} = 0 V, T _J = 125 °C	-	-	100		
		V _{DS} = 120 V, V _{GS} = 0 V, T _J = 150°C	-	-	5	mA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	90	-	-	Α	
Drain Course On State Resistance 3	J	$V_{GS} = 10 \text{ V}, I_D = 60 \text{ A}$	-	0.0062	-		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 25 A	-	0.0069	-	Ω	
Forward Transconductance ^a g _{fs} V _D		V _{DS} = 15 V, I _D = 20 A	-	60	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	5500	-	pF	
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 75 \text{V}, f = 1 \text{ MHz}$	-	846	-		
Reverse Transfer Capacitance	C _{rss}		-	32	-		
Total Gate Charge ^c	Q_g		-	100	-	nC	
Gate-Source Charge ^c	Q _{gs}	$V_{DS} = 7.5 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	30	-		
Gate-Drain Charge ^c	Q_{gd}		-	25	35		
Gate Resistance	R_g	f = 1 MHz	-	0.9	1.2	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	18	-		
Rise Time ^c	t _r	V_{DD} = 75 V, R_L = 1.66 Ω	-	50	-	ns	
Turn-Off Delay Time ^c	t _{d(off)}	$I_D\cong 50$ A, V_{GEN} = 10 V, R_g = 1 Ω	-	75	-		
Fall Time ^c	t _f		-	55	-		
Drain-Source Body Diode Ratings ar	nd Characteri	stics ^b (T _C = 25 °C)					
Pulsed Current (t = 100 μs)	I _{SM}		-	-	100	А	
Forward Voltage ^a	V _{SD}	I _F = 500 A, V _{GS} = 0 V	-	0.84	1.3	V	
Reverse Recovery Time	t _{rr}		-	85	120	ns	
Peak Reverse Recovery Charge	I _{RM(REC)}	$I_F = 50 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	11	20	Α	
Reverse Recovery Charge	Q _{rr}		-	0.8	1.0	μC	

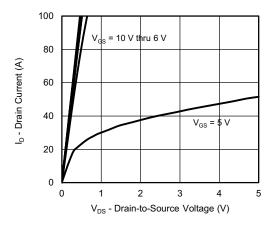
Notes

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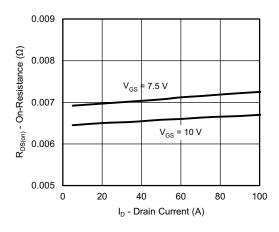
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.



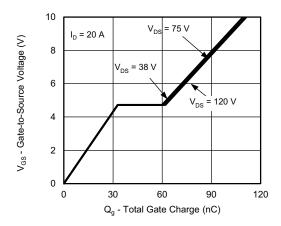
TYPICAL CHARACTERISTICS ($T_C = 25$ °C, unless otherwise noted)



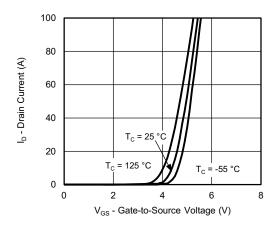
Output Characteristics



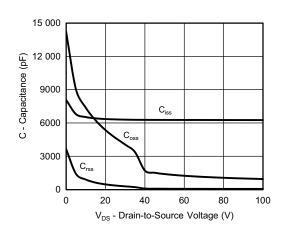
On-Resistance vs. Drain Current and Gate Voltage



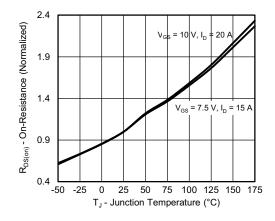
Gate Charge



Transfer Characteristics



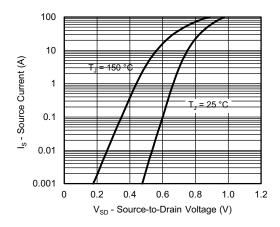
Capacitance



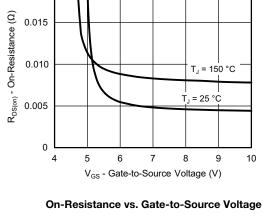
On-Resistance vs. Junction Temperature



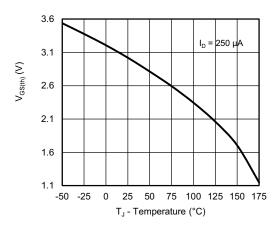
I_D = 20 A



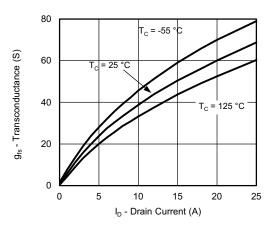
Source-Drain Diode Forward Voltage



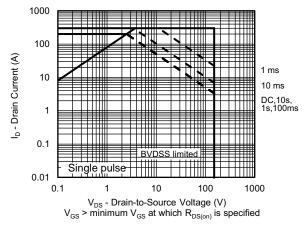
0.020



Threshold Voltage

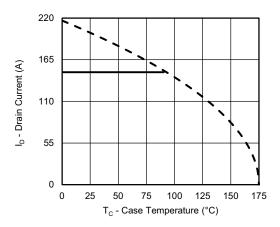


Transconductance

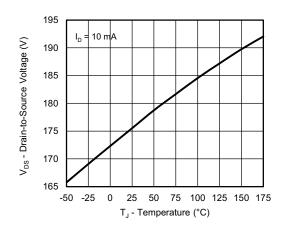


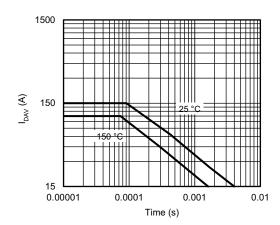
Safe Operating Area, Junction-to-Ambient





Current Derating a





Drain Source Breakdown vs. Junction Temperature

 I_{DAV} vs. Time

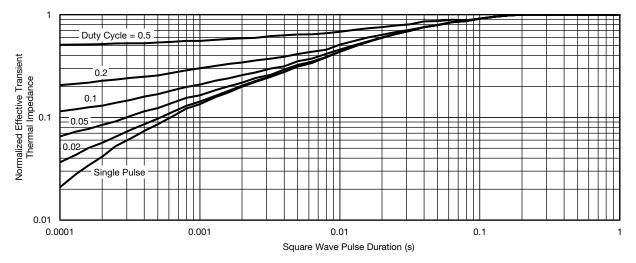
Note

a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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THERMAL RATINGS (T_C = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

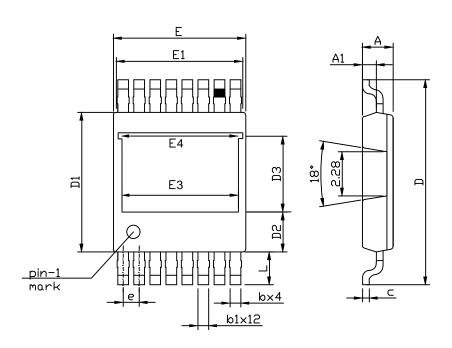
Note

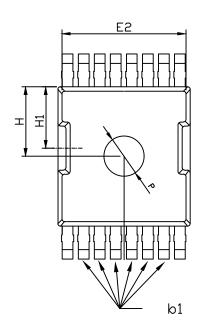
- The characteristics shown in the two graphs Normalized Transient Thermal Impedance Junction to Ambient (25 $^{\circ}\text{C})$
- Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single

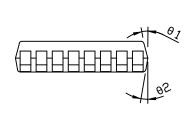
pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

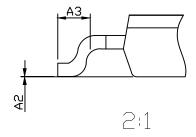


Package Outlines









UNIT: mm

UNII . IIIIII								
SYMBOLS	Α	A1	A2	A3	b	b1	С	D
MIN	2.25	1.00	0.01		0.68	0.75	0.45	14.80
NOM	2.30	1.04	0.08	1.50REF	0.70	0.85	0.50	15.00
MAX	2.35	1.08	0.16		0.74	0.95	0.55	15.20
SYMBOLS	D1	D2	D3	Е	E1	E2	E3	E4
MIN	10.00	2.40		9.70				
NOM	10.10	2.60	5.77REF	9.90	9.46REF	9.25REF	8.25REF	8.70REF
MAX	10.30	2.80		10.10				
SYMBOLS	е	Н	H1	L	Р	1	2	
MIN	1.18	5.00	4.40	2.40	2.80	7 °	7 °	
NOM	1.20	5.20	4.60	2.45	3.00	-	-	
MAX	1.22	5.40	4.80	2.50	3.20	9°	9°	



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